

SEARCHED

Subclass

13

99

81-82

103

E33.001

E33.003

E33.062

E33.012

E33.014

Class

257

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Application/Control No.

Applicant(s)/Patent under Reexamination

10/517,877

GOTO ET AL.
Art Unit

2822

Examiner

Thanh Y. Tran

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HED	
Date	Examiner
1/2/2008	TYT

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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	ce search printout	1/2/2008	TYT		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted: Scott Geyer Updated east search (see search history printout).	1/2/2008	TYT		
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